

承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:				
客戶料號 CUSTOMER'S P/N	:				
料號 PART NUMBER	:	WAN1608H2	45H04		
規格 DESCRIPTION	:	Chip Antenna 1	608 LH Ant 2.45G	Type H04	V
版本 VERSION	:	V1.4			
日期 ISSUE DATE	:	2023/06/15		KT,	
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	7	0	工程部]
e			R&D CENTER		
CID C		承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN	
		Ray	Tennyson	Snow	





萬誠科技股份有限公司

112 台北市北投區立功街 151 號 1 樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

1F, No. 151, Li Gong Street, Beitou District,

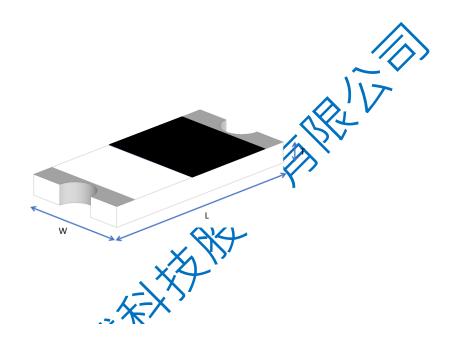
Taipei City 112, Taiwan TEL: +886 2 2898-2220

FAX: +886 2 2898-5055



1608 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN1608H245H04

	7 ,	
		Dimension (mm)
	L	1.62 ± 0.20
	W	0.83 ± 0.20
	Т	0.29 ± 0.20
Y		



Part Number Information

WAN 1608

A	Product Series Antenna			
В	Dimension L x W	1.62X0.83mm (± 0.2mm)		
C	Material High K material			
D	Working Frequency	2.4 ~ 2.5GHz		
E	Feeding mode	PIFA & Single Feeding		
F	Antenna type	Type = 04		

1. Electrical Specification

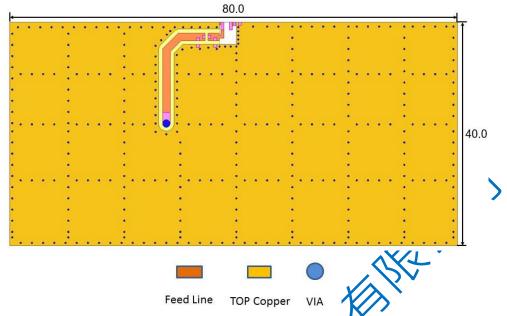
A	Product Series	Antenna			
B Dimension L x W		1.62X0.83mm (± 0.2mm)			
C	Material	High K material			
D	Working Frequency	2.4 ~ 2.5GHz			
\mathbf{E}	Feeding mode	PIFA & Single Feeding ~			
F	Antenna type	Type = 04	7		
Electrical Specification					
	Spe	ecification			
	Part Number	WAN1608H245H04			
	Central Frequency	2450	MHz		
	Bandwidth	85 (Min.)	MHz		
	Return Loss	-6.5 (Max)	dB		
	Peak Gain	1.73	dBi		
	Impedance	50	Ohm		
Operating Temperature		-40~+110	$^{\circ}\!\mathbb{C}$		
Maximum Power		4	W		
Resist	tance to Soldering Heats	10 (@ 260°C)	sec.		
O ,	Polarization	Linear			
A	Azimuth Beamwidth	Omni-directional			
	Termination	Cu / Sn (Leadless)			

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



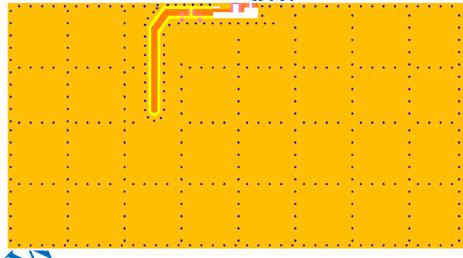
2. Recommended PCB Pattern

Evaluation Board Dimension (board size 80x40mm)



2nd Evaluation Board Dimension

Evaluation Board Dimension (board size 80x40mm)



Suggested Matching Circuit

重要資訊:

匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF

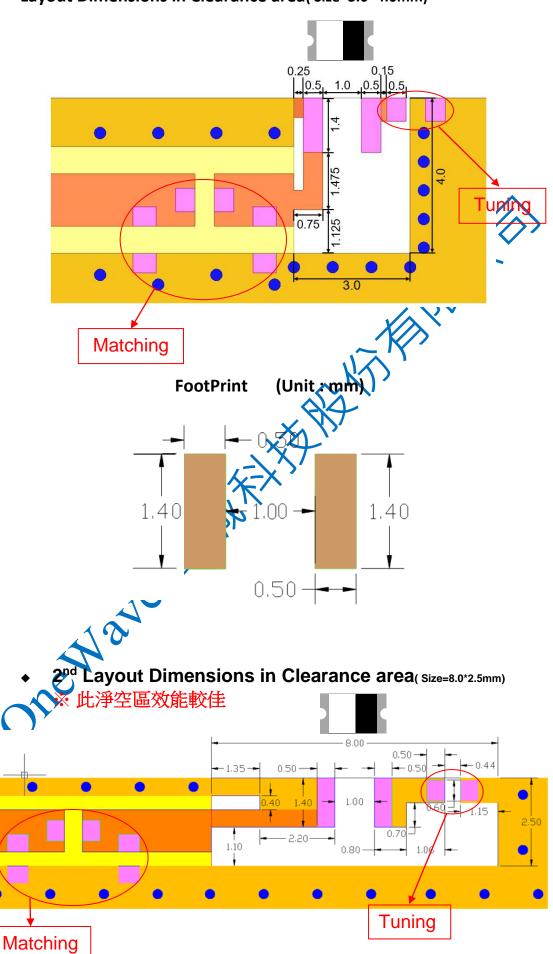
Matching Circuit

6.8nH
Feeding

1.0pF
None

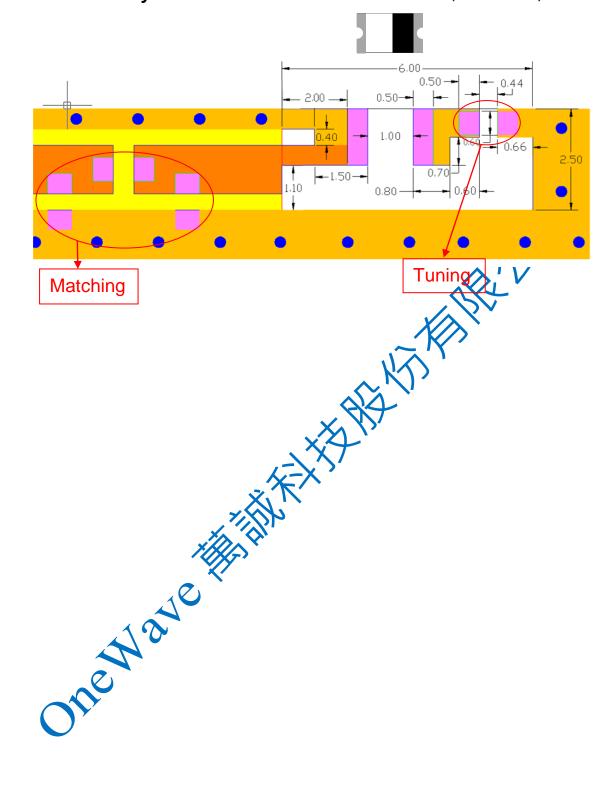


Layout Dimensions in Clearance area(Size=3.0*4.0mm)





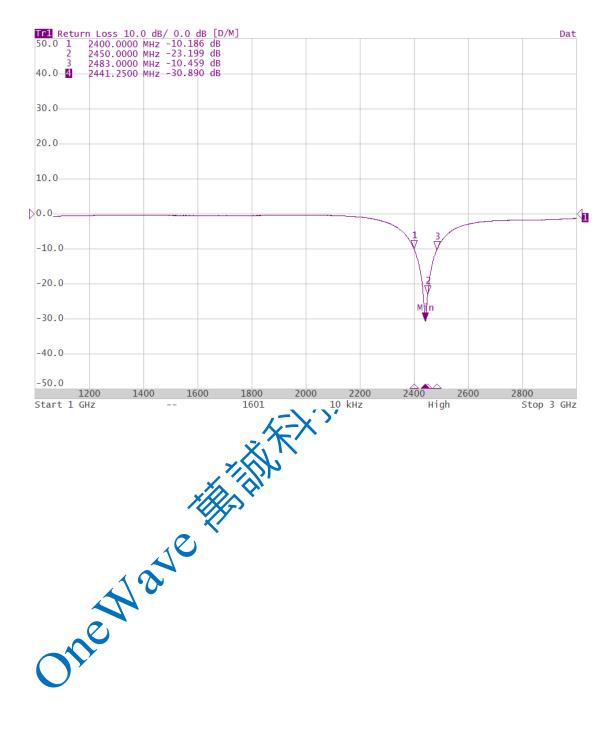
◆ 3rd Layout Dimensions in Clearance area(Size=6.0*2.5mm)





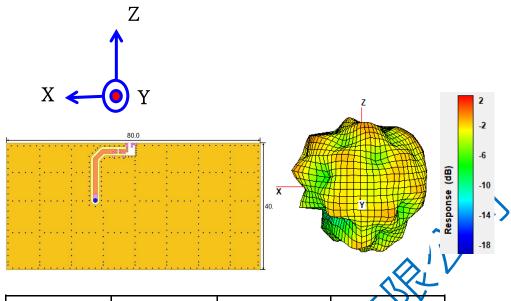
3. Measurement Results

Return Loss



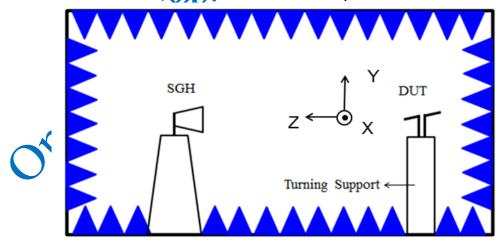


Radiation Pattern



	Efficiency	Peak Gain	Directivity
2400MHz	69.36 %	1.62 dBi	3.20 dBi
2450MHz	74.31 %	1.73 dBi	3.01 dBi
2500MHz	70.53 %	1.65 dBi	3.16 dBi

Chamber Coordinate System





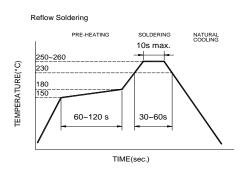
4.Reliability and Test Condictions

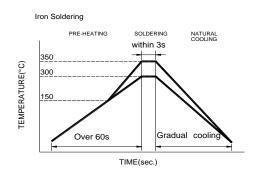
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	1. Wetting shall exceed 90% coverage 2. No visible mechanical damage TEMP (°C) 230°C 4±1 sec. 60sec	Pre-heating temperature:150°C/60sec. Solder temperature:230±5°C Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
Solder heat Resistance	1. No visible mechanical damage 2. Central Freq. change :within ± 6% TEMP (°C) 260°C 150°C 10±0.5 sec.	Pre-heating temperature:150°C/60sec. Solder temperature:260±5°C Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
Component Adhesion (Push test)	No visible mechanical damage	The device should be reflow soldered(230±5°C for 10sec.) to a tinned copper substrate A dynameter force gauge should be applied the side of the component. The device must with ST-F 0.5 Kg without failure of the termination attached to component.		
Component	No visible mechanical damage	Insert 10cm wire into the remaining open eye		
Adhesion	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	bend ,the ends of even wire lengths upward		
(Pull test)	\sim	and wind together.		
	,- <u>,- ,- ,- ,- ,- ,- ,- ,- ,- ,- ,- ,- ,- ,</u>	Terminal shall not be remarkably damaged.		
Thermal shock	No visible mechanical damage	+110°C =>30±3min -40°C =>30±3min		
	2. Central Freq. change :within ±6%	Test cycle:10 cycles		
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal condition		
	1 +110±5°C 30±3	for 2~3 hours before measuring.		
	2 Room Within Temperature 3sec			
	3 -40±2°C 30±3			
	4 Room Within			
	Temperature 3sec			
Resistance to	1 No visible mechanical damage	Temperature: +110±5°C		
High	No visible mechanical damage Control Frog. change :within +6%	Duration: 1000±12hrs		
Temperature	2. Central Freq. change :within ±6%	The chip shall be stabilized at normal condition		
^	3. No disconnection or short circuit.	for 2~3 hours before measuring.		
Resistance to	No visible mechanical damage	Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	No disconnection or short circuit.	The chip shall be stabilized at normal condition		
	5. NO disconnection of short circuit.	for 2~3 hours before measuring.		
Humidity	No visible mechanical damage	Temperature: 40±2°C		
•	Central Freq. change :within ±6%	Humidity: 90% to 95% RH		
	3. No disconnection or short circuit.	Duration: 1000±12hrs		
	5. INO GISCOTHECTION OF SHORE CITCUIT.	The chip shall be stabilized at normal condition		
		for 2~3 hours before measuring.		



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

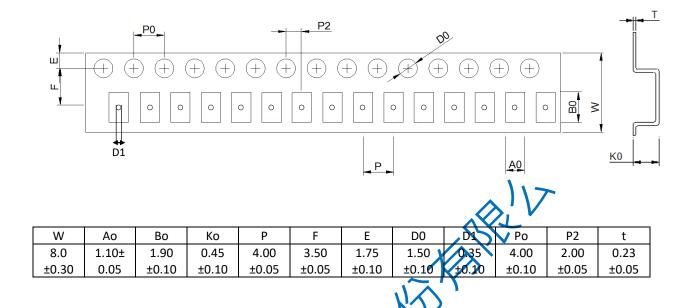
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

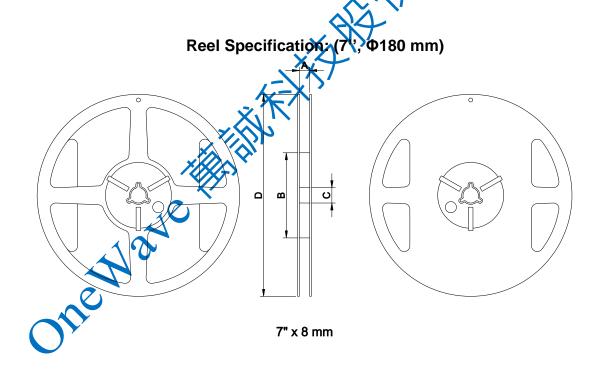
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 wattsoldering iron with tip diameter of 1.0mm
- 280° (tip temperature (max))
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



6.Packaging Information

Tape Specification:





Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.